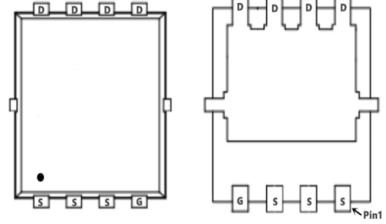
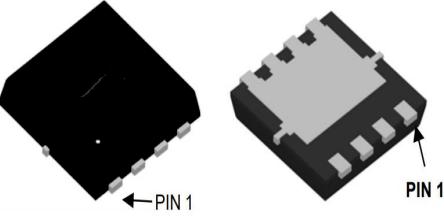
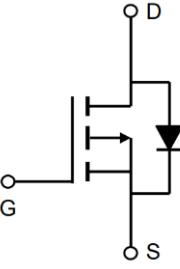


<p><b>General Description</b></p> <ul style="list-style-type: none"> <li>• Low <math>R_{DS(ON)}</math></li> <li>• RoHS and Halogen-Free Compliant</li> </ul> <p><b>Applications</b></p> <ul style="list-style-type: none"> <li>• Load switch</li> <li>• PWM</li> </ul>	<p><b>General Features</b></p> <p><math>V_{DS} = -20V</math> <math>I_D = -60A</math></p> <p><math>R_{DS(ON)} = 6.6\text{ m}\Omega(\text{typ.})</math> @ <math>V_{GS} = -4.5V</math></p> <p>100% UIS Tested 100% <math>R_g</math> Tested</p> 
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 <p>Marking 70P02</p>	<p>DF:DFN3x3_8L</p>  <p>PIN 1</p> 
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### Absolute Maximum Ratings ( $T_c=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	-20	V
$V_{GS}$	Gate-Source Voltage	$\pm 12$	V
$I_D@T_c=25^\circ C$	Continuous Drain Current, $V_{GS} @ -4.5V^1$	-60	A
$I_D@T_c=70^\circ C$	Continuous Drain Current, $V_{GS} @ -4.5V^1$	-38	A
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	-220	A
$P_D@T_c=25^\circ C$	Total Power Dissipation <sup>3</sup>	42	W
$T_{STG}$	Storage Temperature Range	-55 to 150	°C
$T_J$	Operating Junction Temperature Range	-55 to 150	°C

### Thermal Data

Symbol	Parameter	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction Ambient <sup>1</sup>	75	°C/W

## Electrical Characteristics ( $T_J=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
<b>Off Characteristic</b>						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_D = -250\mu\text{A}$	-20	-	-	V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}} = -20\text{V}, V_{\text{GS}} = 0\text{V},$	-	-	-1	$\mu\text{A}$
$I_{\text{GSS}}$	Gate to Body Leakage Current	$V_{\text{DS}} = 0\text{V}, V_{\text{GS}} = \pm 12\text{V}$	-	-	$\pm 100$	nA
<b>On Characteristics</b>						
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_D = -250\mu\text{A}$	-0.5	-1.0	-1.5	V
$R_{\text{DS}(\text{on})}$ note3	Static Drain-Source on-Resistance	$V_{\text{GS}} = -4.5\text{V}, I_D = -15\text{A}$	-	6.6	8.5	$\text{m}\Omega$
		$V_{\text{GS}} = -2.5\text{V}, I_D = -12\text{A}$	-	8	12	
<b>Dynamic Characteristics</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}} = -10\text{V}, V_{\text{GS}} = 0\text{V}, f = 1.0\text{MHz}$	-	4600	-	pF
$C_{\text{oss}}$	Output Capacitance		-	460	-	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		-	459	-	pF
$Q_g$	Total Gate Charge	$V_{\text{DS}} = -10\text{V}, I_D = -15\text{A}, V_{\text{GS}} = -4.5\text{V}$	-	56	-	nC
$Q_{\text{gs}}$	Gate-Source Charge		-	8	-	nC
$Q_{\text{gd}}$	Gate-Drain("Miller") Charge		-	16	-	nC
<b>Switching Characteristics</b>						
$t_{\text{d}(\text{on})}$	Turn-on Delay Time	$V_{\text{DD}} = -10\text{V}, I_D = -13\text{A}, R_{\text{GEN}} = 2.7\Omega, V_{\text{GS}} = -10\text{V}$	-	11	-	ns
$t_r$	Turn-on Rise Time		-	110	-	ns
$t_{\text{d}(\text{off})}$	Turn-off Delay Time		-	157	-	ns
$t_f$	Turn-off Fall Time		-	160	-	ns
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
$I_s$	Maximum Continuous Drain to Source Diode Forward Current		-	-	-60	A
$I_{\text{SM}}$	Maximum Pulsed Drain to Source Diode Forward Current		-	-	-220	A
$V_{\text{SD}}$	Drain to Source Diode Forward Voltage	$V_{\text{GS}} = 0\text{V}, I_s = -30\text{A}$	-	-	-1.2	V
$\text{trr}$	Reverse Recovery Time	$T_J = 25^\circ\text{C}, I_{\text{SD}} = -15\text{A}, V_{\text{GS}} = 0\text{V}, dI/dt = -100\text{A}/\mu\text{s}$	-	23	-	ns
$Q_{\text{rr}}$	Reverse Recovery Charge		-	14	-	Nc

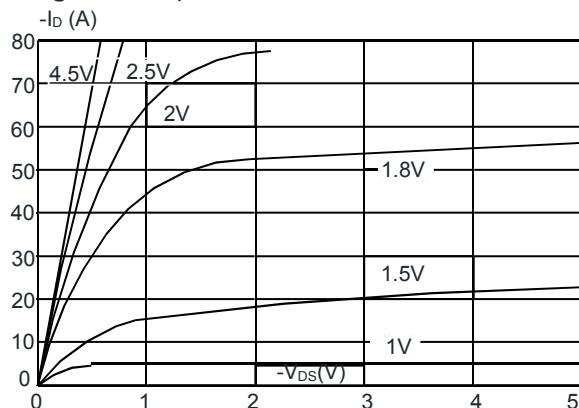
Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

2. EAS condition:  $T_J = 25^\circ\text{C}, V_{\text{DD}} = -10\text{V}, V_{\text{G}} = -10\text{V}, R_{\text{G}} = 5.9\Omega, L = 0.5\text{mh}, I_{\text{AS}} = -16\text{A}$

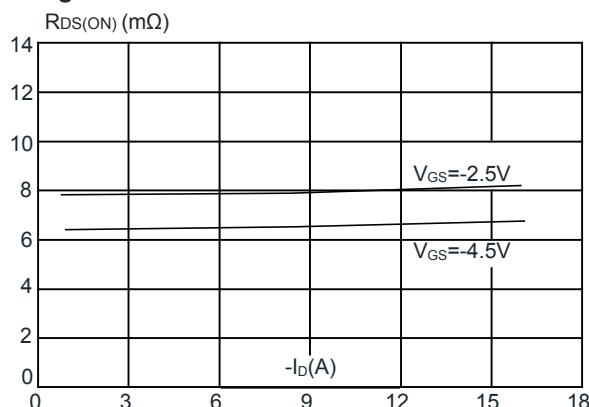
3. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 0.5\%$

## Typical Performance Characteristics

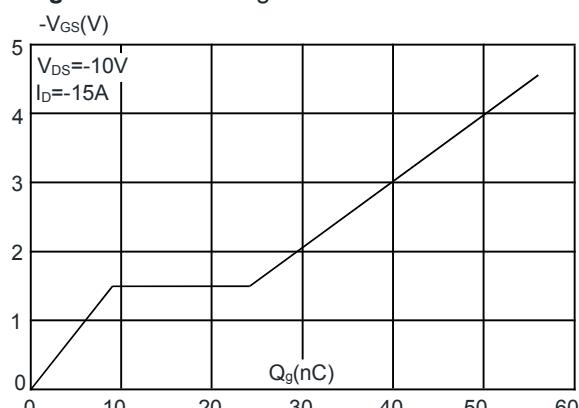
**Figure 1:** Output Characteristics



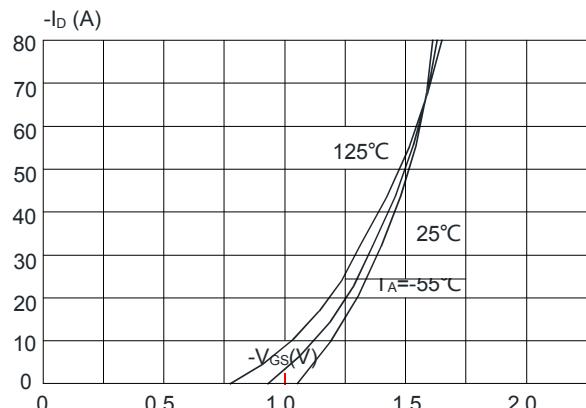
**Figure 3:** On-resistance vs. Drain Current



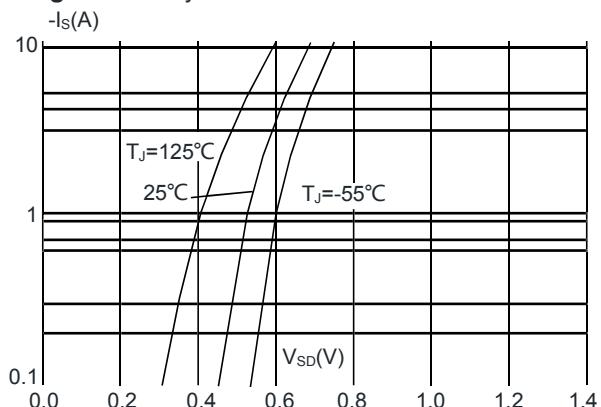
**Figure 5:** Gate Charge Characteristics



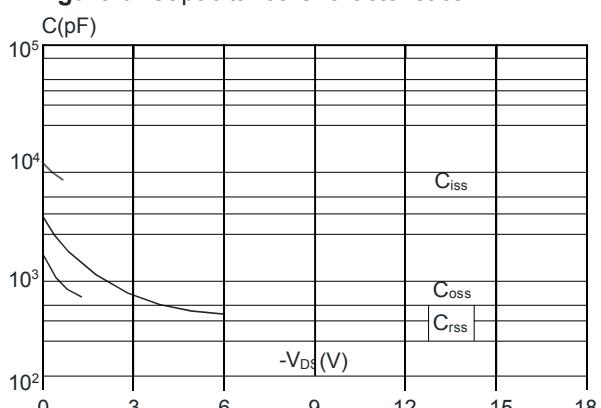
**Figure 2:** Typical Transfer Characteristics



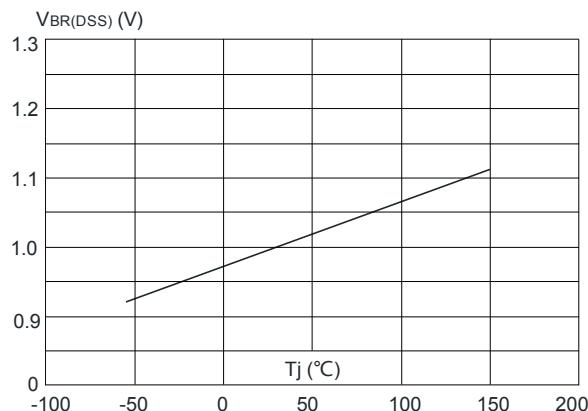
**Figure 4:** Body Diode Characteristics



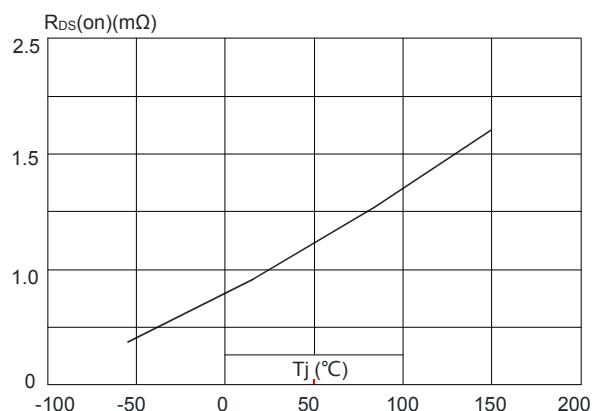
**Figure 6:** Capacitance Characteristics



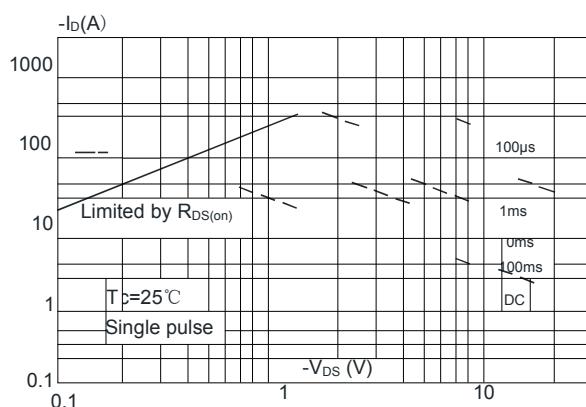
**Figure 7:** Normalized Breakdown Voltage vs. Junction Temperature



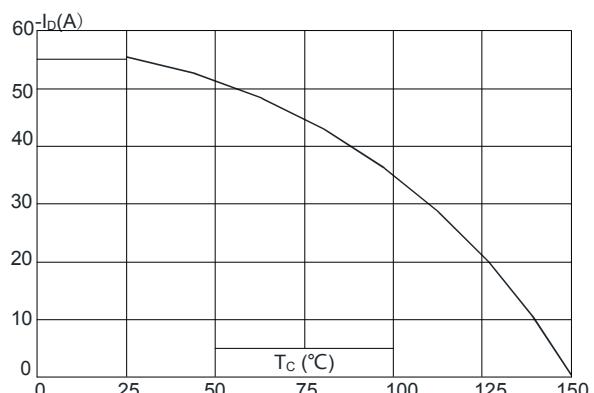
**Figure 8:** Normalized on Resistance vs. Junction Temperature



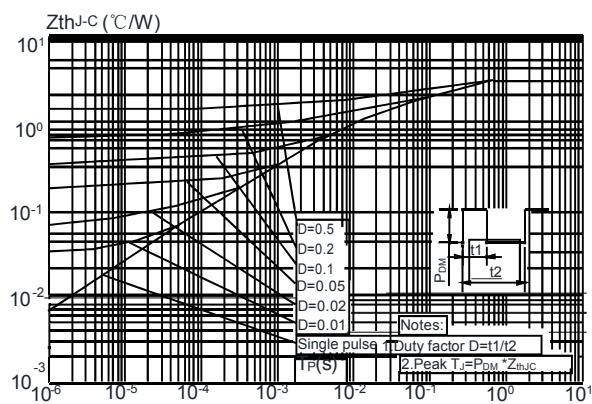
**Figure 9:** Maximum Safe Operating Area



**Figure 10:** Maximum Continuous Drain Current vs. Case Temperature

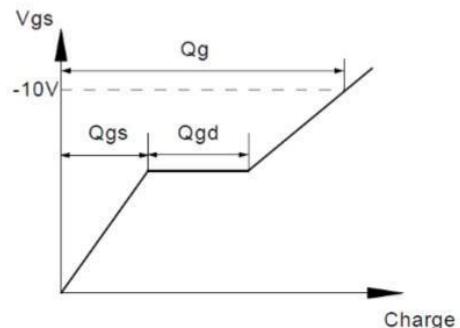
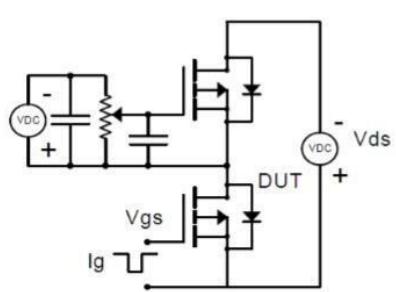


**Figure 11:** Maximum Effective Transient Thermal Impedance, Junction-to-Case

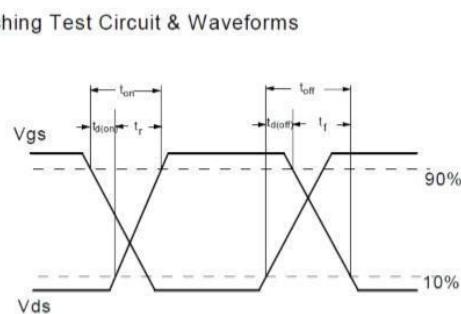
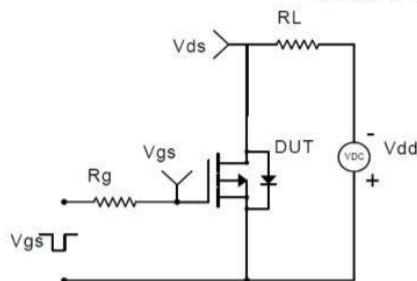


## Test Circuit

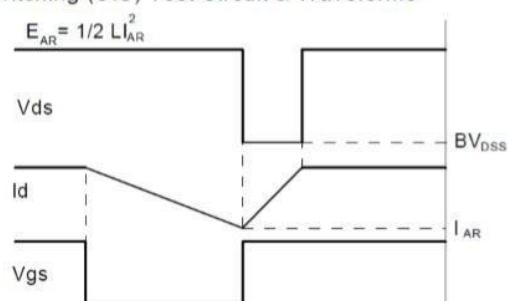
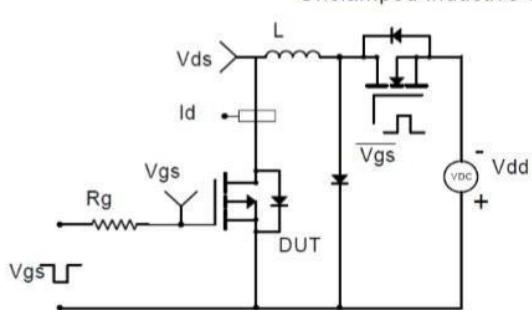
Gate Charge Test Circuit & Waveform



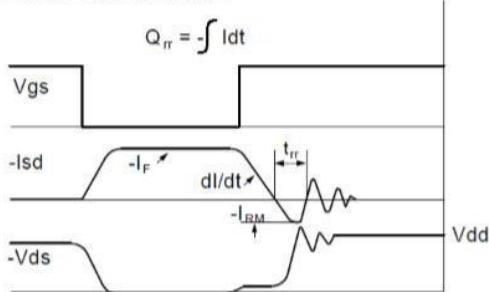
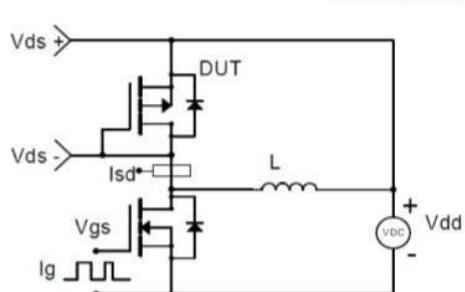
Resistive Switching Test Circuit & Waveforms



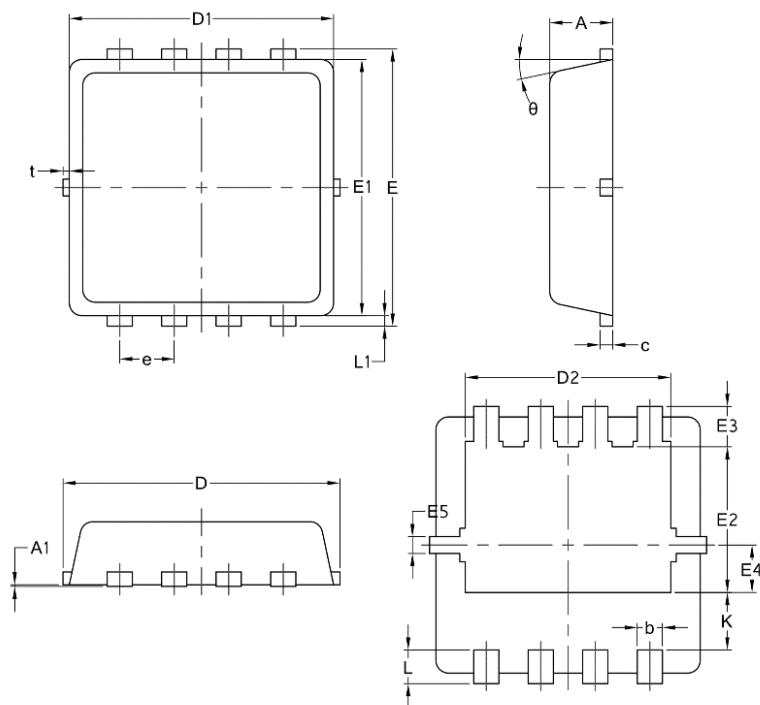
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



## Package Mechanical Data:DFN3x3-8L



Symbol	Common		
	mm		
	Mim	Nom	Max
A	0.70	0.75	0.85
A1	/	/	0.05
b	0.20	0.30	0.40
c	0.10	0.152	0.25
D	3.15	3.30	3.45
D1	3.00	3.15	3.25
D2	2.29	2.45	2.65
E	3.15	3.30	3.45
E1	2.90	3.05	3.20
E2	1.54	1.74	1.94
E3	0.28	0.48	0.65
E4	0.37	0.57	0.77
E5	0.10	0.20	0.30
e	0.60	0.65	0.70
K	0.59	0.69	0.89
L	0.30	0.40	0.50
L1	0.06	0.125	0.20
t	0	0.075	0.13
Φ	10	12	14